


<b>Search Notes</b>  	<b>Application/Control No.</b>  10509376	<b>Applicant(s)/Patent Under Reexamination</b>  STRANDBERG ET AL.
	<b>Examiner</b>  Pablo N Tran	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	186.1, 3.01, 3.02, 3.06, 414.1-414.3, 142, 344, 188.1, 553.1, 552.1, 550.1, 403, 500, 517, 466, 73-74, 556.1, 185.1, 180.1, 184.1, 158.4, 426.1, 427, 12.1, 557	7/6/10	PT
348	E7.071	7/6/10	PT
709	217, 231, 223, 219, 232	7/6/10	PT

SEARCH NOTES		
Search Notes	Date	Examiner
East/West	7/6/10	PT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Pablo N Tran/ Primary Examiner.Art Unit 2618
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